

**Versions with Markings to Show Changes Made**

1. (AMENDED) A data transfer arrangement comprising:  
two bus drivers;  
a voltage precharge source;  
a differential bus coupled to the bus drivers and to the voltage precharge  
source; and  
  
a latching sense amplifier coupled to the differential bus;  
wherein the latching sense amplifier comprises:  
a first stage including a cross-coupled latch coupled to a differential  
data bus; and  
  
an output stage coupled to an output of said first stage;  
wherein the output of the first stage is coupled to an input of the output  
stage.
  
3. (AMENDED) The data transfer arrangement in accordance with claim 1  
wherein the bus drivers [**consist of**] comprise active pull-up and active pull-down bus drivers.

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Claims Appendix

1. (AMENDED) A data transfer arrangement comprising:  
two bus drivers;  
a voltage precharge source;  
a differential bus coupled to the bus drivers and to the voltage precharge  
source; and  
a latching sense amplifier coupled to the differential bus;  
wherein the latching sense amplifier comprises:  
a first stage including a cross-coupled latch coupled to a differential  
data bus; and  
an output stage coupled to an output of said first stage;  
wherein the output of the first stage is coupled to an input of the output  
stage.
2. (CANCELED)
3. (AMENDED) The data transfer arrangement in accordance with claim 1  
wherein the bus drivers comprise active pull-up and active pull-down bus drivers.
4. (NEW) The data transfer arrangement in accordance with claim 1, wherein the  
first stage of the latching sense amplifier comprises:  
a plurality of input pass transistors each having a gate, a source terminal, and a  
drain; and  
a plurality of NMOS and PMOS transistors each having a gate, a source  
terminal, and a drain;  
wherein the drains of the input pass transistors are coupled to the drains of the  
cross-coupled latch amplifier NMOS and PMOS transistors, each source terminal of the input pass  
transistors is coupled to an input, the sources of the cross-coupled latch amplifier NMOS transistors  
are coupled to the drain of the NMOS transistor coupled to a clock signal input, and the sources of  
the PMOS transistors are coupled to the drain of the PMOS transistor having a gate coupled to an  
inverted clock signal input.

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5. (NEW) The data transfer arrangement in accordance with claim 1, wherein the output stage of the latching sense amplifier comprises:

a plurality of input transistors each having a gate, a source terminal, and a drain; and

a pair of cross-coupled PMOS transistors each having a gate, a source terminal, and a drain;

a first PMOS transistor having a gate, a source terminal, and a drain, the gate being coupled to a clock signal input; the source being coupled to the source of the first of the cross-coupled PMOS transistors; and the drain being coupled to the drain of the first of the input transistors; and

a second PMOS transistor having a gate, a source terminal, and a drain, the gate being coupled to a clock signal input; the source being coupled to the source of a second of the cross-coupled PMOS transistors; and the drain being coupled to the drain of the second of the input transistors;

wherein the sources of the input transistors are coupled to a source of an NMOS transistor having a gate coupled to a clock signal input;

wherein the sources of the cross-coupled PMOS transistors are coupled to a voltage supply, the drains of the cross-coupled PMOS transistors are coupled to the drains of the input transistors; and

wherein the drains of the cross-coupled transistors provide a true and a complement phase of a data output signal.

6. (NEW) The data transfer arrangement in accordance with claim 1, wherein the voltage precharge source is configured to precharge the differential bus to a predetermined voltage that is less than a logic high voltage and greater than a logic low voltage.

7. (NEW) The data transfer arrangement in accordance with claim 1 further comprising a precharge circuit coupled between the precharge source and the differential bus.

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8. (NEW) The data transfer arrangement in accordance with claim 3 wherein the active pull up and pull down bus drivers are NMOS transistors.

9. (NEW) A method of operation of a data transfer arrangement comprising:  
two bus drivers;  
a voltage precharge source;  
a differential bus coupled to the bus drivers and to the voltage precharge source; and  
a latching sense amplifier coupled to the differential bus;  
wherein the latching sense amplifier comprises:  
a first stage including a cross-coupled latch coupled to a differential data bus; and  
an output stage coupled to an output of said first stage;  
wherein the output of the first stage is coupled to an input, and  
wherein the sense amplifier operates in two phases:  
a precharge phase and a data transfer phase;  
wherein the precharge phase operates when a control input clock signal is low, said phase comprising the steps of:  
isolating the cross-coupled latch amplifier from a plurality of power buses by turning off an NMOS transistor coupled to the clock signal input and a PMOS transistor coupled to the inverted clock signal input;  
passing a bus voltage swing to a plurality of internal nodes IT and IC of the latched amplifier;  
precharging both dynamic gates to Vdd; and  
providing a high true phase and a high complement phase of a data output signal; and  
wherein the data transfer phase operates when a control input clock signal is high, said phase comprising the steps of:  
isolating the internal nodes of the latched amplifier from the bus lines by turning off the pass input transistors;

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connecting the cross-coupled latched amplifier to power buses by turning on an NMOS transistor coupled to the clock signal input and a PMOS transistor coupled to an inverted clock signal input;

amplifying each low voltage swing of the internal nodes to full logic levels;

discharging an output node of one of the dynamic gates to ground; and providing a low true phase and a low complement phase of the data output signal.

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